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CHARACTER OF INTERACTION AND GLASS FORMATION IN THE TIAs₂Se₃Te-TIAs₂Te₃Se SYSTEM

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Abstract. The character of the interaction in the TlAs₂Se₃Te–TlAs₂Te₃Se system was studied by the methods of DTA, RFA, MSA, and also by measuring the microhardness and determining the density. State diagram of the system was constructed. It was established that the TlAs₂Se₃Te–TlAs₂Te₃Se system is partially a quasibinary section of the quaternary As, Tl//Se, Te system. One congruently melting compound TlAs₂Se₂Te₂ is formed in the system at 548 K. Solid solutions based on TlAs₂Se₃Te at room temperature reach up to 10 mol % TlAs₂Te₃Se, and solid solutions on the basis of TlAs₂Te₃Se are practically not detected. All the samples obtained are vitreous.

Keywords: congruently, eutectic, quasi-binary, solid solutions, chalcogenides.

1. Introduction

It is known that arsenic chalcogenides and their alloys are IR transparent and widely used in optical information processing systems, in particular, in elements of acousto-optical devices and targets for video codes [1-3].

In the recent years, ternary and more complex systems involving arsenic chalcogenides and other metal chalcogenides have been widely used as semiconductor and luminescent material in electronic engineering [4, 5].

In the literature on the interaction of arsenic and thallium chalcogenides, much information is available on ternary and quaternary systems [6-11]. The system $TlAs_2Se_3Te-TlAs_2Te_3Se$ is investigated for the first time. The purpose of this work is to study the nature of the chemical interaction and glass formation in the $TlAs_2Se_3Te-TlAs_2Te_3Se$ system, as well as the detection of semiconductor phases.

The TlAs₂Se₃Te compound melts congruently at 498 K and crystallizes in a hexagonal system with lattice parameters: a = 10.66; c = 9.05 Å, $\rho = 6.78 \cdot 10^3 \text{ kg/m}^3$ [12]. The TlAs₂Te₃Se compound melts incongruently at 513 K and crystallizes in tetragonal system with lattice parameters: a = 10.83; c = 9.32 Å, $\rho = 7.4 \cdot 10^3 \text{ kg/m}^3$ [12].

2. Experimental

The alloys of the $TlAs_2Se_3Te-TlAs_2Te_3Se$ system were synthesized by an ampoule method in a single-temperature vertical furnace at 773-973 K. Taking into account the peritectic nature of the $TlAs_2Te_3Se$ formation, in order to achieve completeness of reaction, the quaternary compound was annealed below the peritectic temperature (503 K) for 500 h.

Interaction in the $TlAs_2Se_3Te$ – $TlAs_2Te_3Se$ system was studied by differential thermal (DTA), X-ray diffraction (XRD), microstructural (MSA) analyses, as well as microhardness and density determination.

DTA scans were made using a TERMOSCAN-2 thermal analyzer, calibrated chromel-alumel thermocouples, and Al $_2$ O $_3$ as a reference substance. The heating rate was 10 K/min. X-ray diffraction patterns were studied on a D-2 PHASER model diffractometer using Cu $_\alpha$ radiation with a Ni-filter. The microstructure of the alloys of the TlAs $_2$ Se $_3$ Te–TlAs $_2$ Te $_3$ Se system was examined with a metallographic MIM-8 microscope on pre-etched sections, polished with GOI paste. The microstructure was revealed by an etchant with the composition of 10 ml conc. NaOH: 5 ml of C $_2$ H $_5$ OH = 1:1, etching time 20 s. The microhardness of the alloys was studied at the PMT-3 installation at 0.15 loads. The densities of the system alloys were determined by a pycnometric method, toluene was used as the working fluid.

3. Results and Discussion

The samples obtained are compact and black in color. At room temperature, all samples of the TlAs₂Se₃Te–TlAs₂Te₃Se system are resistant to air organic solvents and mineral acids. When heated, mineral

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acids (HNO₃, H₂SO₄) and alkalis (NaOH, KOH) decompose them. Annealing of the alloys of the TlAs₂Se₃Te–TlAs₂Te₃Se system was carried out at 453 and 523 K for 740 h. Crystallization of the glassy alloys was monitored by periodic studies of DTA, XRD, density determination, and microhardness measurements.

DTA results show that almost all fixed on the heating and cooling curves are irreversible. On the thermograms of the system alloys, three series of softening point values (T_g) were found. For TlAs₂Se₃Te, $T_g = 423 \,\mathrm{K}$, for TlAs₂Se₂Te₂ $T_g = 383 \,\mathrm{K}$ and for TlAs₂Te₃Se $T_g = 408 \,\mathrm{K}$.

To determine the region of glass formation, XRD, MCA, microhardness measurements, and determination of the density of alloys of the system before and after annealing were carried out.

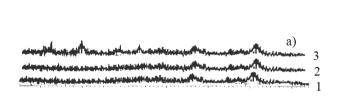
The MSA of the alloys of the $TlAs_2Se_3Te-TlAs_2Te_3Se$ system shows that all the alloys are glassy. After annealing, the thermograms of the alloys from the glass region lack softening temperatures. The microstructures of these alloys show that, in addition to alloys containing 0-10 mol % of $TlAs_2Te_3Se$ and

50 mol % of $TlAs_2Te_3Se$, all alloys are two-phase and three-phase alloys.

XRD cast alloys of the system showed that on the diffractograms of alloys containing 20, 40 and 70 mol % of TlAs₂Te₃Se, no diffraction maxima were observed (Fig. 1a). After annealing on the diffractograms of the above alloys, intense diffraction maxima appear (Fig. 1b).

Given the conchoidal fracture, the presence of thermal effects of softening temperatures on thermograms, the absence of diffraction maxima in diffractograms and finally, the absence of crystalline inclusions, one can judge glasses.

Thus, it was found that all the alloys of the TlAs₂Se₃Te–TlAs₂Te₃Se system under ordinary conditions are obtained in the glassy form. Based on the physico-chemical analysis, a phase diagram of the TlAs₂Se₃Te–TlAs₂Te₃Se system was constructed (Fig. 2). It was established that a compound of the composition TlAs₂Se₂Te₂ and a melting incoherent at 548 K is formed in the system. Using the methods of physical and chemical research, the existence of the TlAs₂Se₂Te₂ compound was confirmed.



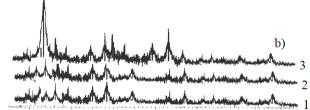


Fig. 1. Diffractograms of alloys of the TlAs₂Se₃Te–TlAs₂Te₃Se system containing 20 (1), 40 (2) and 70 (3) mol % of TlAs₂Te₃Se before (a) and after (b) annealing

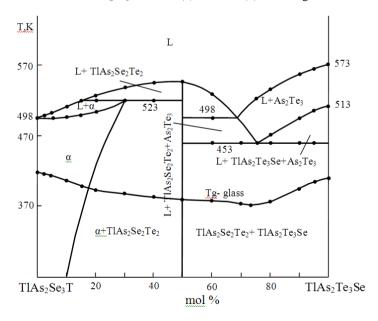


Fig. 2. Phase diagram of the TlAs₂Se₃Te–TlAs₂Te₃Se system

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Table 1
Composition, DTA results, microhardness measurements and determination of the density of alloys of the TIAs₂Se₃Te-TIAs₂Te₃Se system before annealing

Composition, mol %				Microhardness, MPa			
TlAs ₂ Se ₃ Te	TlAs ₂ Te ₃ Se	Thermal effects, K	Density, 10^3kg/m^3	α	$TlAs_2Se_2Te_2$	TlAs ₂ Te ₃ Se	
11AS ₂ SC ₃ 1C	11AS21C3SC			P = 0.15 N			
100	0	423, 498	6.55	820	-	_	
97	3.0	418, 503	6.57	830		_	
95	5.0	413, 498, 503	6.61	880	ı	_	
90	10	408, 508, 518	6.65	920	-	_	
85	15	403, 508, 523	6.67	920		_	
80	20	398, 513, 523, 533	6.72	920	-	_	
70	30	393, 523, 538	6.80	-	1100	-	
60	40	388, 523, 543	6.86	_	1100	-	
50	50	383, 548	6.95	-	1060	-	
40	60	383, 453, 493, 533	6.97	-	1080	_	
30	70	378, 453	6.99	-		-	
25	75	473, 453, 528	7.00	-	-	_	
20	80	383, 453, 473, 538	7.04			890	
10	90	398, 453, 493, 563	7.08	-	_	900	
5.0	95	408, 453, 508, 568	7.10	_		900	
0.0	100	413, 513, 573	7.12			870	

Table 2
Composition, DTA results, microhardness measurements and density determination of alloys of the TlAs₂Se₃Te-TlAs₂Te₃Se system after annealing

Composition, mol %				Microhardness, MPa		
TlAs ₂ Se ₃ Te TlAs ₂ Te ₃ S	TIA CTO SO	Thermal effects, K	Density, $10^3 \cdot \text{kg/m}^3$	α	TlAs ₂ Se ₂ Te ₂	TlAs ₂ Te ₃ Se
	11AS21C3SC			P = 0.15 N		
100	0	498	6.78	680	-	_
97	3.0	503	6.80	690	_	_
95	5.0	498, 503	6.83	700	-	_
90	10	508, 518	6.87	700	-	_
85	15	508, 523	6.89	740	-	_
80	20	513, 523, 533	6.93	740	-	_
70	30	523, 538	6.97	eutect.	eutect.	_
60	40	523, 543	7.05	_	800	_
50	50	548	7.12	_	760	_
40	60	453, 493, 533	7.12	_	770	_
30	70	453	7.14	_	770	_
25	75	453, 528	7.15	_	-	_
20	80	453, 473, 538	7.17	_	-	600
10	90	453, 493, 563	7.18	_		600
5.0	95	453, 508, 568	7.20	_	_	600
0.0	100	513, 573	7.20	_	_	570

From the measurements of the microhardness of cast alloys of the $TIAs_2Se_3Te-TIAs_2Te_3Se$ system, three series of values are different (Tables 1, 2). The first one corresponds to the microhardness of the dark α -phase (solid solutions based on $TIAs_2Se_3Te$, 820-920 MPa), the microhardness value within 1060-1100 MPa corresponds to the new phase of $TIAs_2Se_2Te_2$, and the microhardness value within 870-900 MPa corresponds to the $TIAs_2Te_3Se$

compound. After annealing, the microhardness for α -solid solutions is 680–740 MPa, for TlAs₂Se₂Te₂ it is equal to 760–800 MPa, and for TlAs₂Te₃Se – to 570–600 MPa.

The density of vitreous alloys before and after annealing differs markedly (Tables 1, 2). In the $TlAs_2Se_3Te-TlAs_2Te_3Se$ system, the boundaries of solid solutions based on $TlAs_2Se_3Te$ are extending up to 10 mol % $TlAs_2Se_3Te$, and on the basis of $TlAs_2Te_3Se$

solid solutions are practically not detected. To clarify the region of glass formation in the TlAs₂Se₃Te–TlAs₂Te₃Se system, XRD was carried out before and after annealing.

The liquidus of the $TlAs_2Se_3Te-TlAs_2Te_3Se$ system consists of three branches of primary crystallization of the α -phase (solid solutions based on $TlAs_2Se_3Te$), a new phase of $TlAs_2Se_2Te_2$ and $TlAs_2Te_3Se$.

In the concentration range of 0–30 mol % $TlAs_2Te_3Se$, the primary crystallization of the α -phase takes place along the liquidus line. Within the range of 15–70 mol % $TlAs_2Te_3Se$, the phase is first released from the liquid, and in the range of 70–100 mol % $TlAs_2Te_3Se$ the As_2Te_3 compound is released from the liquid. Above the temperature of 513 K, the $TlAs_2Te_3Se$ compound decomposes according to the reaction: $TlAs_2Te_3Se \leftrightarrow L + As_2Te_3$.

Therefore, in the range of 75–100 mol % $TlAs_2Te_3Se$ below the liquidus line, there are three-phase mixtures (L + As_2Te_3 + $TlAs_2Te_3Se$). Within 0–10 mol % below the solidus line, single-phase alloys (α) crystallize, in the range of 10–50 mol % $TlAs_2Te_3Se$ crystallizes biphase alloys (α + $TlAs_2Se_2Te_2$), and in the range of 50–100 mol % $TlAs_2Te_3Se$ alloys crystallize ($TlAs_2Te_3Se$ + $TlAs_2Se_2Te_2$).

4. Conclusions

The phase diagram of the TlAs₂Se₃Te–TlAs₂Te₃Se system was studied by DTA, RFD, and MSA methods, as well as by measuring of microhardness and density determination, and by constructing state diagram. It is established that the TlAs₂Se₃Te–TlAs₂Te₃Se system is a partially quasi-binary section of the quaternary system As, Tl//Se, Te. In the system at 548 K one congruent-melting compound TlAs₂Se₂Te₂ is formed. Solid solutions based on TlAs₂Se₃Te at room temperature reach 10 mol % TlAs₂Te₃Se, and solid solutions on the basis of TlAs₂Te₃Se are practically not detected. All the samples obtained are vitreous.

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XAPAKTEP ВЗАЄМОДІЇ ТА СКЛОУТВОРЕННЯ В СИСТЕМІ TlAs₂Se₃Te–TlAs₂Te₃Se

Анотація. Характер взаємодії в системі $TlAs_2Se_3Te-TlAs_2Te_3Se$ досліджено за допомогою диференційного термічного, рентгеноструктурного та мікроструктурного методів, а також внаслідок вимірювання мікротвердості та визначення густини. На основі одержаних результатів побудовано діаграму стану. Встановлено, що ділянка $TlAs_2Se_3Te-TlAs_2Te_3Se$ частково є квазібінарною секцією четвертинної системи As, Tl/Se, Te. Показано, що за температури $548 \ K \ y$ системі утворюється одна конгруентноплавка сполука $TlAs_2Se_2Te_2$. Визначено, що область розчинності твердих розчинів на основі $TlAs_2Se_3Te$ за кімнатної температури досягають 10 % мол. $TlAs_2Te_3Se$, а сполуки на основі $TlAs_2Te_3Se$ практично не спостерігаються. Показано, що всі отримані зразки склоподібні.

Ключові слова: конгруентно, евтектичні, квазібінарні, тверді розчини, халькогеніди.